Application/Control No.	Applicant(s)/Patent under Reexamination
09/926,280	BODIN, UIF
Examiner	Art Unit
Line Vene	2665

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST, IEEE, GOOGLE	8/22/2005	LY			
Consulted Steven Nguyen	8/24/2005	LY			
combine text search with classification	8/24/2005	LY			
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